

Search Notes

Application/Control No.

10/064,881

Examiner

Alexander Eisen

Applicant(s)/Patent under
Reexamination

CHANG, YI-CHEN

Art Unit

2674

SEARCHED

Class	Subclass	Date	Examiner
345	76-83	6/20/2005	AE
345	87-102		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST, USPGPUB, USPAT, EPO, JPO, inventor/assignee search	6/20/2005	AE